

DESCRIPTION

The MX3N10G uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. It can be used in a wide variety of applications.

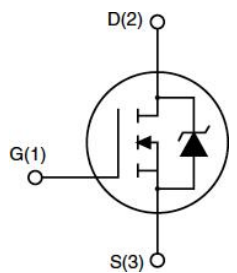
GENERAL FEATURES

- $V_{DS}=100V$, $I_D=2.2A$
 $R_{DS(ON)}(Typ.)=260m\Omega$ @ $V_{GS}=4.5V$
 $R_{DS(ON)}(Typ.)=250m\Omega$ @ $V_{GS}=10V$
- High Density Cell Design for Ultra Low $R_{DS(ON)}$
- Fully Characterized Avalanche Voltage and Current
- Excellent Package for Good Heat Dissipation

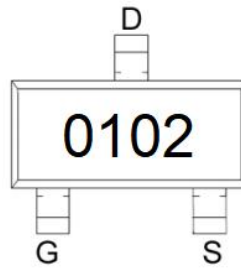
APPLICATION

- Uninterruptible Power Supply(UPS)
- Hard Switched and High Frequency Circuits
- Power Switching application

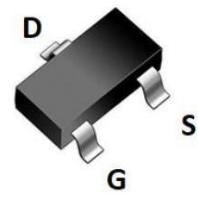
PINOUT



Schematic diagram



Marking and pin Assignment



SOT-23 top view

ORDERING INFORMATION

| Part Number | Marking | StorageTemperature | Package | Devices Per Reel |
|-------------|---------|--------------------|---------|------------------|
| MX3N10G | 0102 | -55°C to 150°C | SOT-23 | - |

ABSOLUTE MAXIMUM RATINGS ($T_C=25^\circ C$ unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|----------------|------------|------------|
| Drain-Source Voltage | V_{DS} | 100 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous | I_D | 2.2 | A |
| Drain Current-Continuous ($T_C=100^\circ C$) | I_D | 1.5 | A |
| Pulsed Drain Current ^(Note1) | I_{DM} | 12 | A |
| Maximum Power Dissipation ($T_A=25^\circ C$) | P_D | 2.5 | W |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ C$ |

THERMAL RESISTANCE

| | | | |
|--|-----------------|----|--------------|
| Thermal Resistance, Junction-to-Ambient ^(Note2) | $R_{\theta JA}$ | 50 | $^\circ C/W$ |
|--|-----------------|----|--------------|

Note 1. Repetitive Rating: Pulse width limited by maximum junction temperature.



ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Conditions | Min | Typ | Max | Unit |
|-----------|--------|------------|-----|-----|-----|------|
|-----------|--------|------------|-----|-----|-----|------|

Off Characteristics

| | | | | | | |
|---------------------------------|------------|-----------------------------|-----|---|-----------|---------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D=250\mu A$ | 100 | - | - | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=100V, V_{GS}=0V$ | - | - | 1.0 | μA |
| Gate-Body Leakage Current | I_{GSS} | $V_{GS}=\pm 20V, V_{DS}=0V$ | - | - | ± 100 | nA |

On Characteristics

| | | | | | | |
|---|--------------|-------------------------------|-----|-----|-----|------------|
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$ | 1.0 | 1.8 | 3.0 | V |
| Drain-Source On-State Resistance ^(Note2) | $R_{DS(ON)}$ | $V_{GS}=4.5V, I_D=1A$ | - | 260 | 310 | m Ω |
| | | $V_{GS}=10V, I_D=2A$ | - | 250 | 280 | m Ω |
| Forward Transconductance | g_{FS} | $V_{DS}=10V, I_D=3A$ | - | 1.1 | - | S |

Dynamic Characteristics

| | | | | | | |
|------------------------------|-----------|-----------------------------------|---|-----|---|----|
| Input Capacitance | C_{iss} | $V_{DS}=50V, V_{GS}=0V, F=1.0MHz$ | - | 330 | - | pF |
| Output Capacitance | C_{oss} | | - | 88 | - | pF |
| Reverse Transfer Capacitance | C_{rss} | | - | 15 | - | pF |

Switching Characteristics

| | | | | | | |
|---------------------|--------------|---|---|-----|---|----|
| Turn-on Delay Time | $t_{d(on)}$ | $V_{DD}=50V, R_L=39\Omega, V_{GS}=10V, R_G=1\Omega$ | - | 14 | - | nS |
| Turn-on Rise Time | t_r | | - | 54 | - | nS |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 18 | - | nS |
| Turn-Off Fall Time | t_f | | - | 11 | - | nS |
| Total Gate Charge | Q_g | $V_{DS}=50V, I_D=1A, V_{GS}=10V$ | - | 5.2 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 1.0 | - | nC |
| Gate-Drain Charge | Q_{gd} | | - | 1.4 | - | nC |

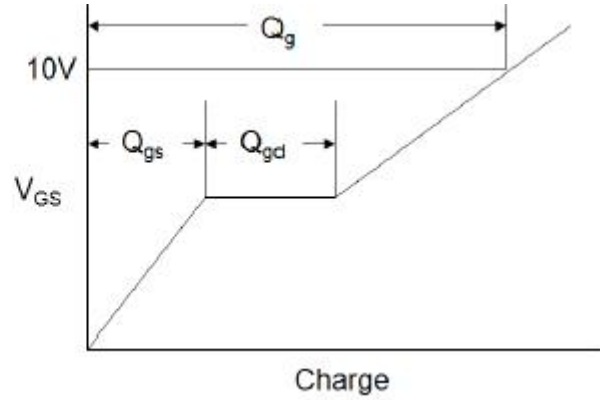
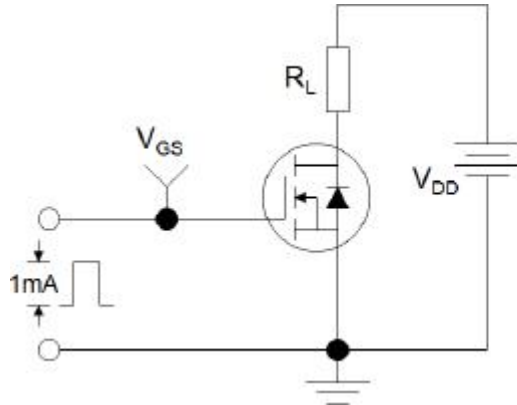
Drain-Source Diode Characteristics

| | | | | | | |
|------------------------------|----------|---------------------|---|---|-----|---|
| Diode Forward Voltage | V_{SD} | $V_{GS}=0V, I_S=1A$ | - | - | 1.2 | V |
| Diode Forward Current | I_S | | - | - | 3 | A |
| Pulsed Diode Forward Current | I_{SM} | | - | - | 12 | A |

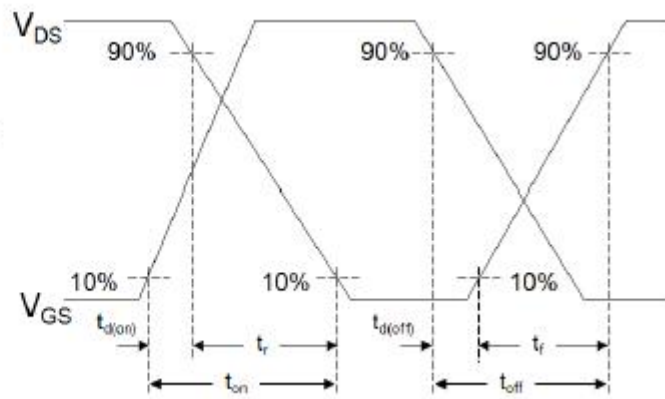
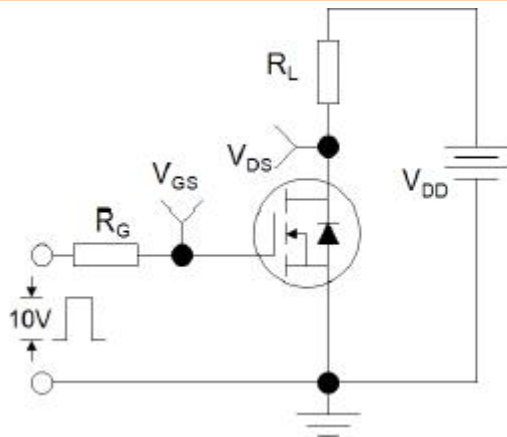
Note 2. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

TEST CIRCUIT

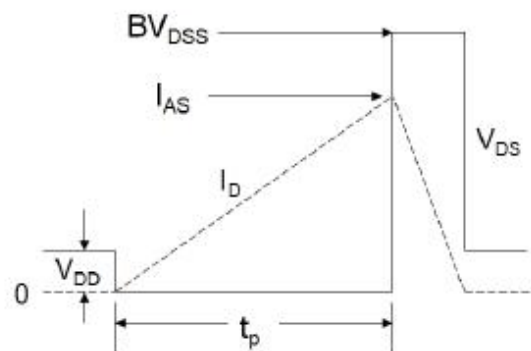
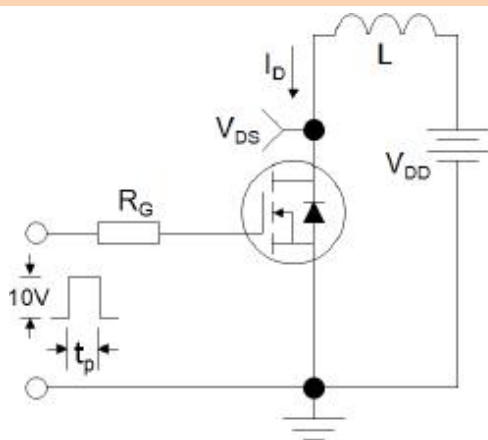
1) Gate Charge Test Circuit & Waveform



2) Resistive Switching Test Circuit & Waveforms

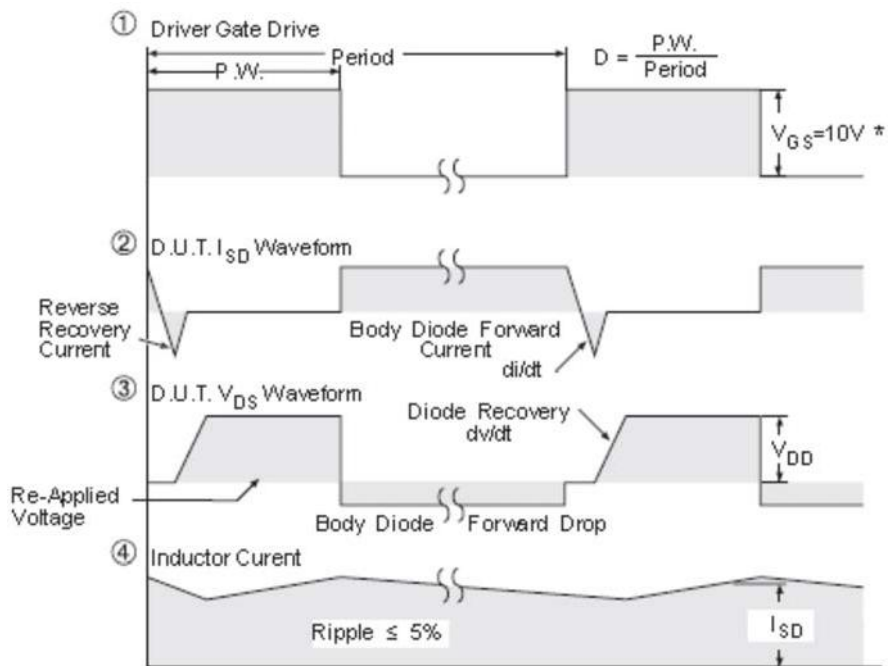
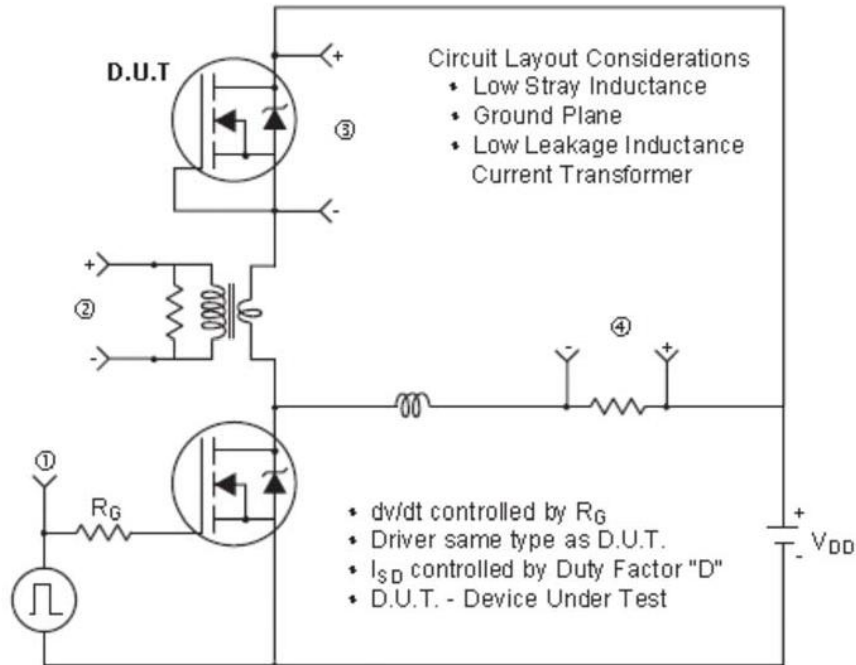


3) Unclamped Inductive Switching Test Circuit & Waveforms



TEST CIRCUIT

4) Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)



* $V_{GS} = 5V$ for Logic Level Devices



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1. Output Characteristics

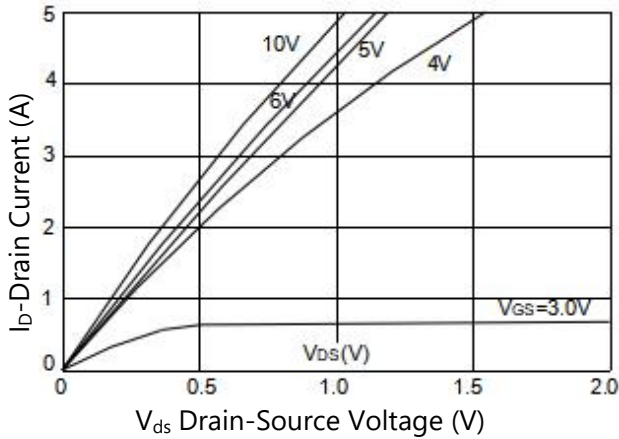


Figure 2. Transfer Characteristics

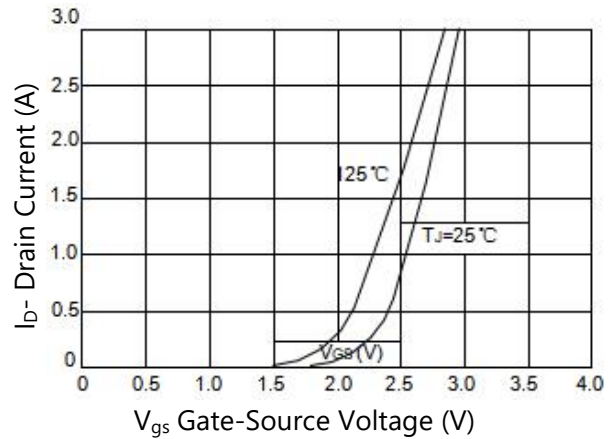


Figure 3. On-resistance vs Drain Current

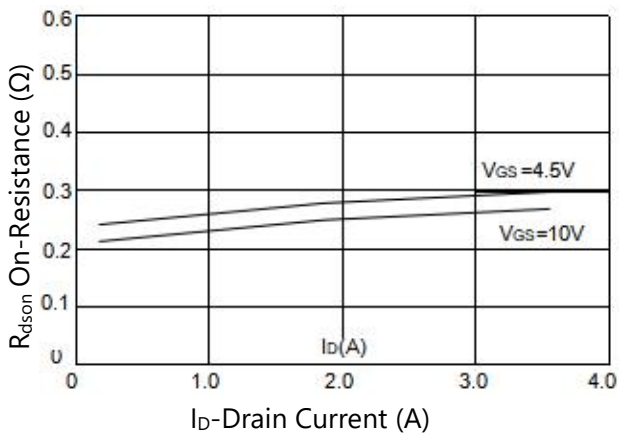


Figure 4. Source-Drain Diode Forward

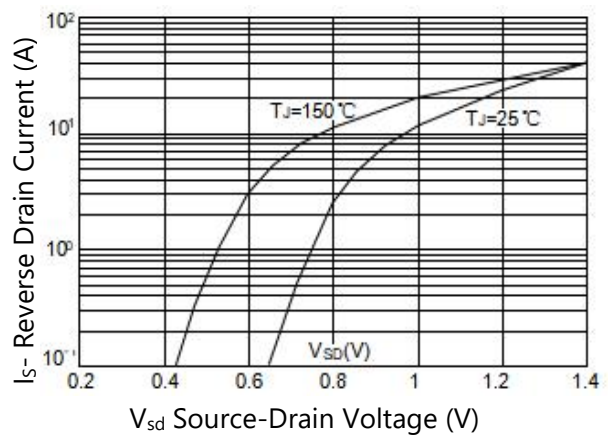


Figure 5. Gate Charge

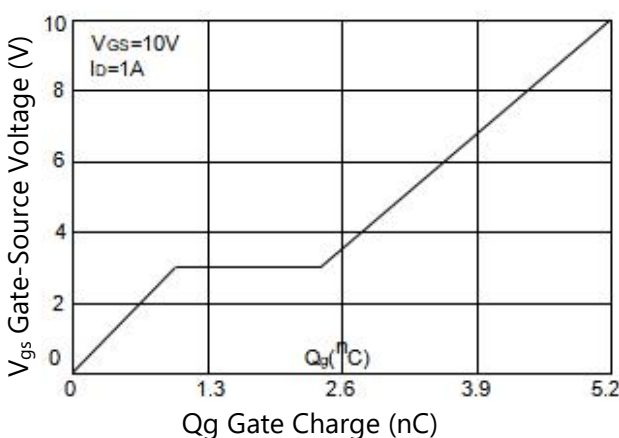
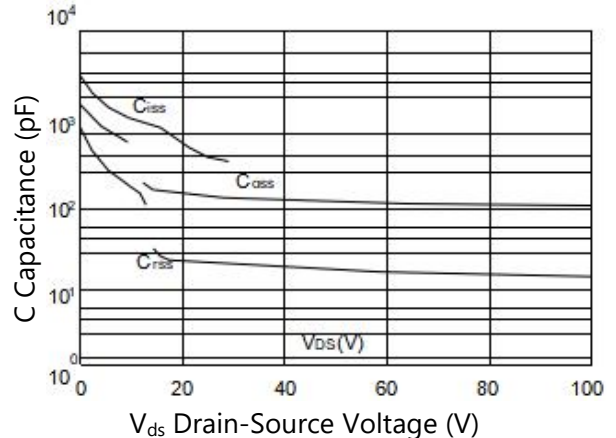


Figure 6. Capacitance Characteristics





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7. BV_{DSS} vs Junction Temperature

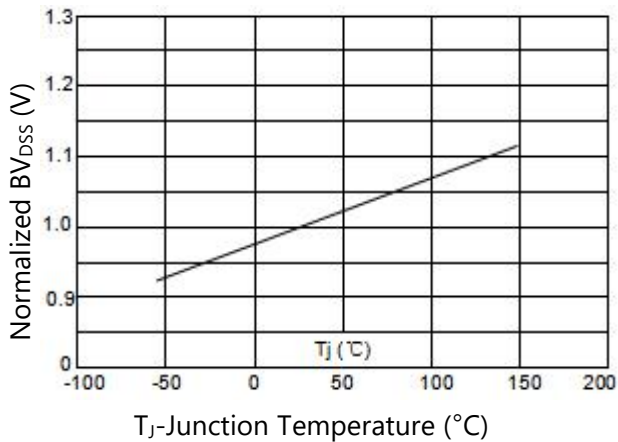


Figure 8. R_{dson} vs Junction Temperature

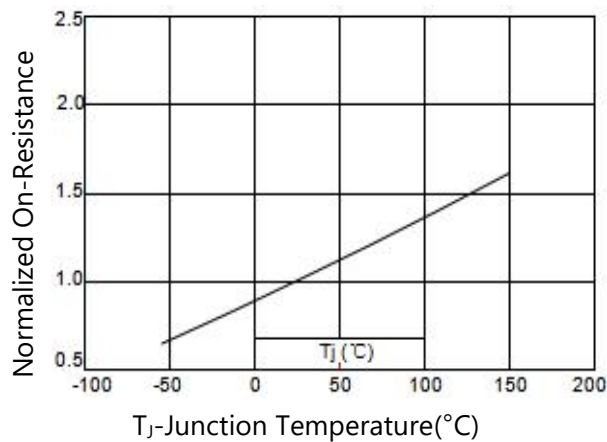


Figure 9. Safe Operation Area

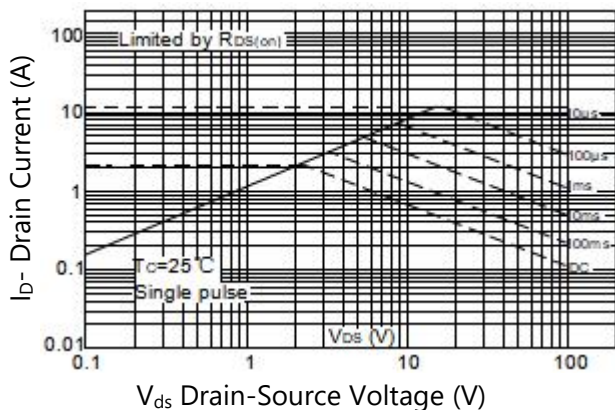


Figure 10. Drain Current vs Case Temperature

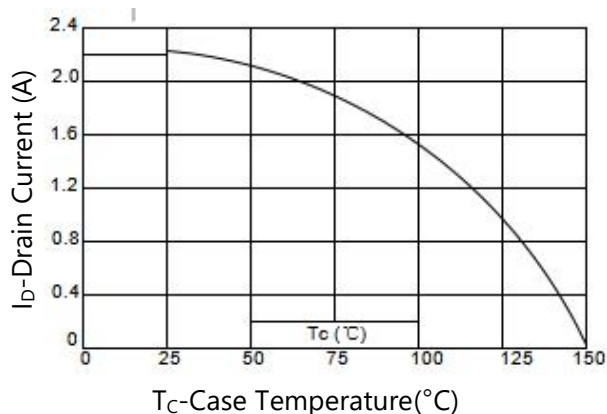
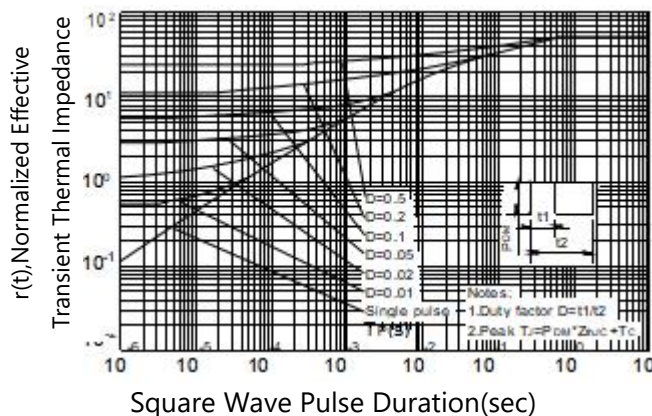
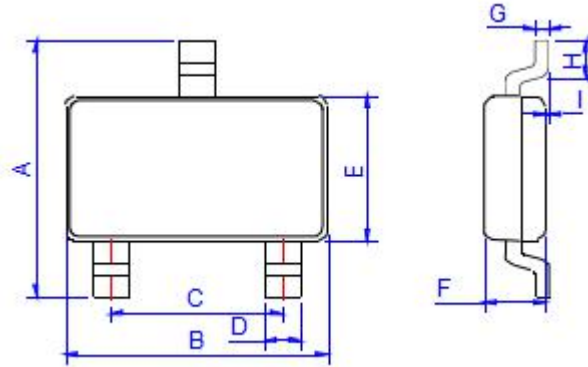


Figure 11. Normalized Maximum Transient Thermal Impedance



 **PACKAGE INFORMATION**

SOT-23



| Symbol | Dimensions in Millimeters | | | Dimensions in Inches | | |
|--------|---------------------------|------|------|----------------------|-------|-------|
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 2.30 | 2.40 | 2.50 | 0.091 | 0.095 | 0.098 |
| B | 2.80 | 2.90 | 3.00 | 0.110 | 0.114 | 0.118 |
| C | 1.90 REF | | | 0.075 REF | | |
| D | 0.35 | 0.40 | 0.45 | 0.014 | 0.016 | 0.018 |
| E | 1.20 | 1.30 | 1.40 | 0.047 | 0.051 | 0.055 |
| F | 0.90 | 1.00 | 1.10 | 0.035 | 0.039 | 0.043 |
| G | - | 0.10 | 0.15 | - | 0.004 | 0.006 |
| H | 0.20 | - | - | 0.008 | - | - |
| I | 0 | - | 0.10 | 0 | - | 0.004 |